

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
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(Use several sheets if necessary)

Date Submitted to PTO: March 25, 2004

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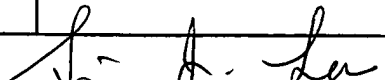
U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
SJL	AF	0 232 972	9/1993	Europe	_____	_____		
	AG	8-3635	1/1996	Japan	_____	_____	yes	
	AH	2001-174993	6/2001	Japan	_____	_____	abstract	
	AI	2002-278069	9/2002	Japan	_____	_____	abstract	
	AJ	2002-371114	12/2002	Japan	_____	_____	abstract	
	AK	2000-206694	7/2000	Japan	_____	_____	abstract	
↓	AL	8-259626	10/1996	Japan	_____	_____	abstract	
	AM							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

SJL ↓	AN	Tsuchiya, Y. et al., Journal of Photopolymer Science and Technology; Vol. 10, No. 4, pp. 579-584, (1997)
	AO	Maeda, K. et al., Journal of Photopolymer Science and Technology; Vol. 11, No. 3, pp. 507-512, (1999).
	AP	Iwasa, S. et al., SPIE Advance in Resist Technology and Processing, Vol. 3333, pp. 417-424, (1998).
EXAMINER 		DATE CONSIDERED 4-15-05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.